Microwave-aided transport measurements on high-density two-dimensional electron systems confined at AlGaN/GaN heterointerfaces

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We present microwave-aided magnetotransport measurements on high-density two-dimensional electron gas (2DEG) systems confined at AlGaN/GaN heterointerfaces. We show that the modulated patterns of Shubnikov-de Haas (SdH) oscillations which are due to higher-subband occupation can be drastically enhanced by employing the microwave modulation technique, allowing direct experimental observation and analysis. In addition, the SdH oscillations can be observed at a much lower magnetic field. Thus we provide a powerful way to study high-density 2DEG systems which possesses higher resolution and enhanced pattern, does not alter carrier concentrations, and merely requires direct data analysis without numerical artifacts compared with conventional measurements.

In the past several years, fundamental properties of Al$_x$Ga$_{1-x}$N/GaN heterostructures have received a great amount of attention for the application of heterostructure-field-effect transistors (HFETs), which are capable of working at high frequencies in high-power and high-temperature environments [1–3]. They are also very promising for applications in microwave and optoelectronic devices. Compared with other III–V material based HFETs, a larger amount of two-dimensional electron gas (2DEG) can be easily accumulated in GaN-based ones. The lattice mismatch of 2.5% between AlN and GaN and the lack of inversion symmetry in the wurtzite structure result in large induced and spontaneous polarizations [2]. Therefore the better carrier confinement at Al$_x$Ga$_{1-x}$N/GaN interface than that at Al$_x$Ga$_{1-x}$As/GaAs interface arising from the large conduction-band offset [3] and strong piezoelectric polarization of the Al$_x$Ga$_{1-x}$N barrier layer naturally leads to a recent research interest in high-carrier-density Al$_x$Ga$_{1-x}$N/GaN heterostructures in which multiple subbands were occupied [4, 5]. In order to optimize the performance of HFETs with high electron densities, it is necessary to be able to probe efficiently the subband properties of 2DEG of high densities at Al$_x$Ga$_{1-x}$N/GaN heterointerfaces.

Shubnikov-de Haas (SdH) measurements are often employed to characterize the properties of 2DEG in different subbands at Al$_x$Ga$_{1-x}$N/GaN heterointerface. When carriers only populate the first subband, the SdH pattern is simple and the analysis is straightforward. As carriers populate the second subband, the SdH pattern has double periodicity and the detailed analysis counts on the effectiveness of numerical methods. In samples with low second-subband carrier population, it is usually difficult to resolve the second periodicity because it is easily obscured by the floating background in the longitudinal resistance $\rho_{xx}(B)$ during fast Fourier transformation. One way to overcome this difficulty is to enhance the sensitiv-
ity and effectiveness of conventional magnetotransport measurements. In this paper, we report on microwave-aided transport measurements on high-density 2DEG confined at AlGaN/GaN heterointerfaces. We show that the modulated patterns of SdH oscillations with multi-frequency can be drastically enhanced by employing the microwave modulation technique, making direct experimental observation and analysis feasible.

We performed SdH measurements on two modulation-doped Al_{0.22}Ga_{0.78}N/GaN heterostructures grown by atmospheric pressure metal-organic chemical vapor deposition on the (0001) surface of sapphire substrates. A nucleation GaN buffer layer was deposited at 488 °C, followed by an unintentionally doped GaN (i-GaN) layer of 2 µm thickness grown at 1071 °C. The barrier layer is a Si-doped Al_{0.22}Ga_{0.78}N (n-AlGaN) layer of thickness 25 nm for sample A and 30 nm for sample B. The doping concentration is 1.2 × 10^{18} cm^{-3}. The one-side doping results in the triangular confinement of carriers in the heterojunctions. Between the n-AlGaN and i-GaN layer, a 5-nm-thick unintentionally doped Al_{0.22}Ga_{0.78}N spacer was inserted for sample A to reduce remote impurity scattering. The samples were placed inside a 6 Tesla Oxford superconducting magnet and immersed in liquid helium. The temperature could be cooled down to as low as 3.6 K. The data were taken by conventional lock-in techniques.

In our studies, we additionally employed a novel technique of SdH measurement that can drastically enhance the SdH pattern, which is based on microwave modulation. Here, the measurements were done electrically in phase under microwave modulation. This method has advantages of unchanging carrier concentration and not diminishing modulation pattern compared with other variant techniques like optically modulated SdH and optically-detected microwave modulated SdH measurements. In our previous report [6], we have shown that this technique is suitable for studying novel wide band-gap heterostructures where moderate mobilities and heavier effective mass (rapid damping SdH amplitudes) are frequently encountered. Detailed experimental setup can be found in one of our previous papers [6].

Figures 1 and 2 show SdH oscillations taken at 3.6 K for sample A and sample B, respectively. The two-dimensional characters have been further confirmed by rotating the sample orientation against the magnetic field. The strong double periodicity of the SdH oscillations is easily recognized for sample A and also exists in sample B, which will be shown below. The modulation doping and the strong polarization field give rise to a large amount of confined 2DEG in the heterointerface. The electrons start to populate the second subband because of the high 2DEG sheet concentrations at the heterointerfaces, resulting in the double periodicity.

It is straightforward to obtain the carrier concentrations corresponding to the first subband from high-frequency oscillations. The successive oscillation numbers as a function of inverse magnetic fields of the SdH oscillation minima for both samples are plotted as solid circles in both insets in Fig. 1 and 2. The data can be described by the simple linear equation [2]

\[
\frac{1}{B_n} = N \frac{e}{\pi \hbar n} + C, \tag{1}
\]

**Fig. 1** (online colour at: www.interscience.wiley.com) Magnetoresistance of 2DEG in Al_{0.22}Ga_{0.78}N/GaN heterostructures as a function of magnetic field at 3.6 K in sample A. The inset shows successive oscillation numbers (solid circles) as a function of inverse magnetic fields of the SdH minimum.
where $B_N$ represents each magnetic field at successive oscillation minimum, $N$ is an integer, $C$ is a constant, and $n$ is the carrier concentration. The choice of the oscillation number is arbitrary. The solid lines in both insets show the fittings to Eq. (1). The slopes of the lines correspond to carrier densities of $8.48 \times 10^{12}$ cm$^{-2}$ for sample A and $9.6 \times 10^{12}$ cm$^{-2}$ for sample B, respectively.

Figures 3a and b display the microwave-modulated SdH patterns at the same temperature under the modulation of a 3.7 GHz microwave radiation for sample A and sample B, respectively. The SdH patterns are considerably enhanced for both samples. It is quite amazing that the visible signal noise is almost washed out and the onset of SdH oscillations is noticeably lowered. For the data taken in sample A, it is significant to note that the short-period oscillations die away at magnetic fields lower than 2.5 Tesla, while the long-period oscillations persist. Therefore we provide direct experimental evidence that the 2DEG in the second subband has a higher mobility than in the first subband in the modulation-doped Al$_{0.22}$Ga$_{0.78}$N/GaN heterostructures by means of microwave-modulated magnetotransport measurements. On the other hand, the resolution of the conventional SdH measurements under similar condition is not capable of comparing these oscillations originated from the two-subband occupancy directly. This shows an advantage of the microwave-modulation technique.

From the fit to Eq. (1), the second-subband carrier density in sample A is determined to be $1.78 \times 10^{12}$ cm$^{-2}$, and the total 2DEG sheet concentration in the triangular well is $1.02 \times 10^{13}$ cm$^{-2}$. Due to the long-period modulation, the double periodicity in sample B is not straightforwardly recognizable in conventional SdH measurement. But the modulated SdH pattern can be readily identifiable in microwave-modulated SdH oscillations, as shown in Fig. 3b. Again, this shows the advantage of the microwave-modulated technique. By the same approach above, the second-subband carrier density is estimated to be...
Thus, the total 2DEG sheet concentration resides in the heterojunction for sample B is $1.01 \times 10^{13} \text{ cm}^{-2}$, which is very close to that for sample A.

In conclusion, we present microwave-aided magnetotransport measurements on high-density 2DEG confined at AlGaN/GaN heterointerfaces. The second-subband population is manifested by the multifrequency in the SdH oscillations. We demonstrated that the modulated patterns of SdH oscillations due to second-subband occupancy can be drastically enhanced by employing the microwave modulation technique. In addition, the SdH oscillations can be observed at a much lower magnetic field. We provide direct experimental evidence that the 2DEG in the second subband has a higher mobility than that in the first subband in the modulation-doped Al$_{0.22}$Ga$_{0.78}$N/GaN heterostructures by means of microwave-modulated magnetotransport measurements. Therefore we offer a powerful method to study high-density 2DEG systems which possesses higher resolution and merely requires direct data analysis compare with conventional measurements.

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